

Development Board EPC9005C Quick Start Guide

40 V Half-Bridge with Gate Drive,
Using EPC2014C

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DESCRIPTION

The EPC9005C development board is a 40 V maximum device voltage, 7 A maximum output current, half bridge with onboard gate drives, featuring the EPC2014C enhancement mode (eGaN®) field effect transistor (FET). The purpose of this development board is to simplify the evaluation process of the EPC2014C eGaN FET by including all the critical components on a single board that can be easily connected into any existing converter.

The EPC9005C development board is 2" x 1.5" and contains two EPC2014C eGaN FET in a half bridge configuration using Texas Instruments LM5113 gate driver, supply and bypass capacitors. The board contains all critical components and layout for optimal switching performance. There are also various probe points to facilitate simple waveform measurement and efficiency calculation. A complete block diagram of the circuit is given in Figure 1.

For more information on the EPC2014Cs eGaN FET please refer to the datasheet available from EPC at www.epc-co.com. The datasheet should be read in conjunction with this quick start guide.

Table 1: Performance Summary ($T_A = 25^\circ\text{C}$)

SYMBOL	PARAMETER	CONDITIONS	MIN	MAX	UNITS
V_{DD}	Gate Drive Input Supply Range		7	12	V
V_{IN}	Bus Input Voltage Range			24*	V
V_{OUT}	Switch Node Output Voltage			40	V
I_{OUT}	Switch Node Output Current			7*	A
V_{PWM}	PWM Logic Input Voltage Threshold	Input 'High' Input 'Low'	3.5 0	6 1.5	V V
	Minimum 'High' State Input Pulse Width	V_{PWM} rise and fall time < 10ns	30		ns
	Minimum 'Low' State Input Pulse Width	V_{PWM} rise and fall time < 10ns	100#		ns

* Assumes inductive load, maximum current depends on die temperature – actual maximum current will be subject to switching frequency, bus voltage and thermals.

Limited by time needed to 'refresh' high side bootstrap supply voltage.

Development Board / Demonstration Board Notification

The EPC9005C board is intended for product evaluation purposes only and is not intended for commercial use. As an evaluation tool, it is not designed for compliance with the European Union directive on electromagnetic compatibility or any other such directives or regulations. As board builds are at times subject to product availability, it is possible that boards may contain components or assembly materials that are not RoHS compliant. Efficient Power Conversion Corporation (EPC) makes no guarantee that the purchased board is 100% RoHS compliant. No Licenses are implied or granted under any patent right or other intellectual property whatsoever. EPC assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or any other intellectual property rights of any kind.

EPC reserves the right at any time, without notice, to change said circuitry and specifications.

QUICK START PROCEDURE

Development board EPC9005C is easy to set up to evaluate the performance of the EPC2014C eGaN FET. Refer to Figure 2 for proper connect and measurement setup and follow the procedure below:

1. With power off, connect the input power supply bus to +V_{IN} (J5, J6) and ground / return to -V_{IN} (J7, J8).
2. With power off, connect the switch node of the half bridge OUT (J3, J4) to your circuit as required.
3. With power off, connect the gate drive input to +V_{DD} (J1, Pin-1) and ground return to -V_{DD} (J1, Pin-2).
4. With power off, connect the input PWM control signal to PWM (J2, Pin-1) and ground return to any of the remaining J2 pins.
5. Turn on the gate drive supply – make sure the supply is between 7 V and 12 V range.

6. Turn on the bus voltage to the required value (do not exceed the absolute maximum voltage of 40 V on V_{OUT}).
7. Turn on the controller / PWM input source and probe switching node to see switching operation.
8. Once operational, adjust the bus voltage and load PWM control within the operating range and observe the output switching behavior, efficiency and other parameters.
9. For shutdown, please follow steps in reverse.

NOTE: When measuring the high frequency content switch node (OUT), care must be taken to avoid long ground leads. Measure the switch node (OUT) by placing the oscilloscope probe tip through the large via on the switch node (designed for this purpose) and grounding the probe directly across the GND terminals provided. See Figure 3 for proper scope probe technique.

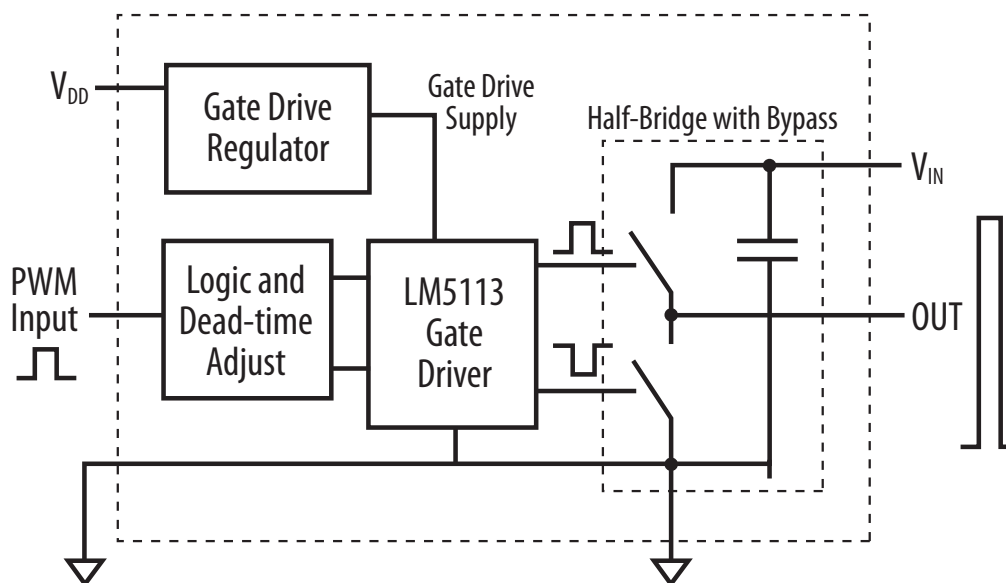


Figure 1: Block Diagram of EPC9005C Development Board

QUICK START PROCEDURE

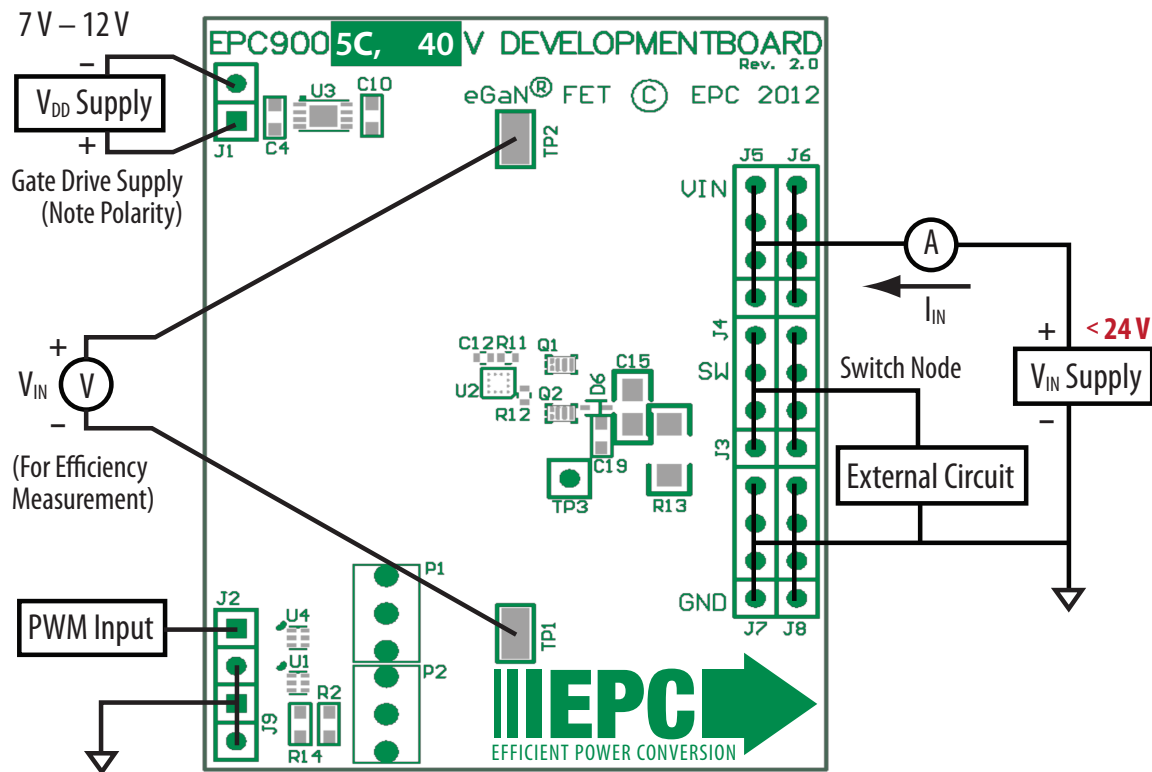


Figure 2: Proper Connection and Measurement Setup

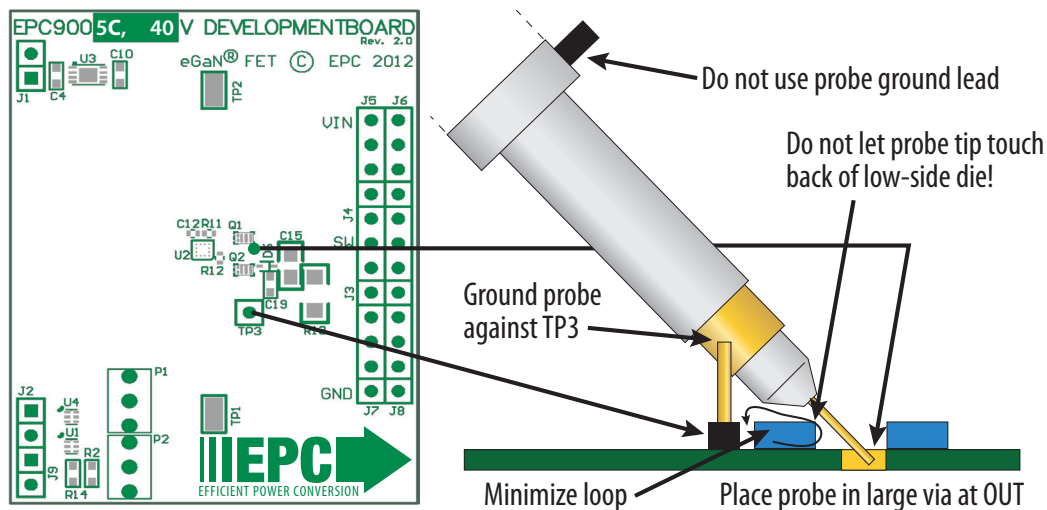


Figure 3: Proper Measurement of Switch Node – OUT

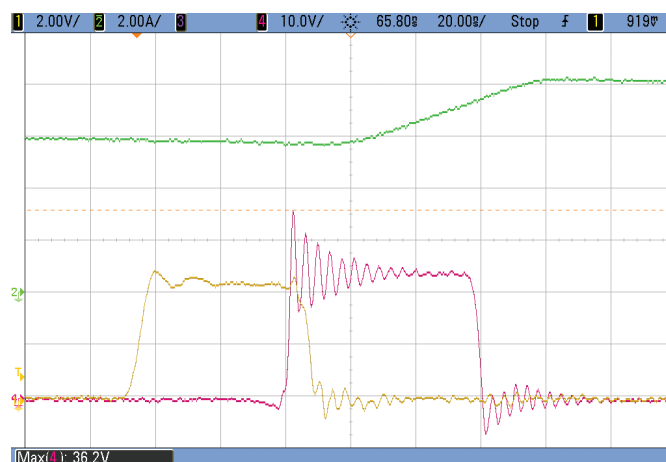


Figure 4: Typical Waveforms for $V_{IN} = 24\text{ V}$ to $1.2\text{ V}/7\text{ A}$ (1000kHz) Buck converter
CH1: V_{pwm} Input voltage – CH2: (I_{out}) Switch node current – CH4: (V_{out}) Switch node voltage

THERMAL PERFORMANCE

The EPC9005C development board showcases the EPC2014C eGaN FET. Although the electrical performance surpasses that for traditional silicon devices, their relatively smaller size does magnify the thermal management requirements. The EPC9005C is intended for bench evaluation with low ambient temperature and convection cooling.

The addition of heat-sinking and forced air cooling can significantly increase the current rating of these devices, but care must be taken to not exceed the absolute maximum die temperature of 125°C . NOTE. The EPC9005C development board does not have any current or thermal protection on board.

Table 2: Bill of Materials

Item	Qty	Reference	Part Description	Manufacturer / Part #
1	4	C4, C10, C11, C13	Capacitor, 1uF, 10%, 25V, X5R	Murata, GRM188R61E105KA12D
2	2	C6, C7	Capacitor, 100pF, 5%, 50V, NP0	TDK, C1608C0G1H101J
3	1	C12	Capacitor, 0.1uF, 10%, 25V, X5R	TDK, C1608X5R1E104K
4	2	C16, C17	Capacitor, 4.7uF, 20%, 50V, X5R	Taiyo Yuden, UMK325BJ475M
5	2	D1, D2	Schottky Diode, 30V	Diodes Inc., SDM03U40-7
6	3	J1, J2, J9, TP3 (See Note 1)	Connector	FCI, 68001-236HLF
7	1	J3, J4, J5, J6, J7, J8	Connector	FCI, 68602-224HLF
8	2	Q1, Q2	eGaN® FET	EPC, EPC2014C
9	1	R1	Resistor, 10.0K, 5%, 1/8W	Stackpole, RMCF0603FT10K0
10	2	R2, R15	Resistor, 0 Ohm, 1/10W	Panasonic, ERJ-3GEY0R00V
11	1	R4	Resistor, 22 Ohm, 1%, 1/8W	Stackpole, RMCF0603FT22R0
12	1	R5	Resistor, 33 Ohm, 1%, 1/8W	Stackpole, RMCF0603FT33R0
13	2	R11, R12	1 Ohm, 1%, 1/8W	Stackpole, RMCF0402TFT1R00
14	2	TP1, TP2	Test Point	Keystone Elect, 5015
15	1	U1	I.C., Logic	Fairchild, NC7SZ00L6X
16	1	U2	I.C., Gate driver	Texas Instruments, LM5113
17	1	U3	I.C., Regulator	Microchip, MCP1703T-5002E/MC
18	1	U4	I.C., Logic	Fairchild, NC7SZ08L6X
19	0	R13, R14	Optional Resistor	
20	0	C15, C19	Optional Capacitor	
21	0	D5, D6	Optional Diode	
22	0	P1, P2	Optional Potentiometer	

Note 1: 36 pin header to be cut as follows J1: cut 2 pins used, J2 & J9: cut 4 pins used, TP3: cut 1 pin used

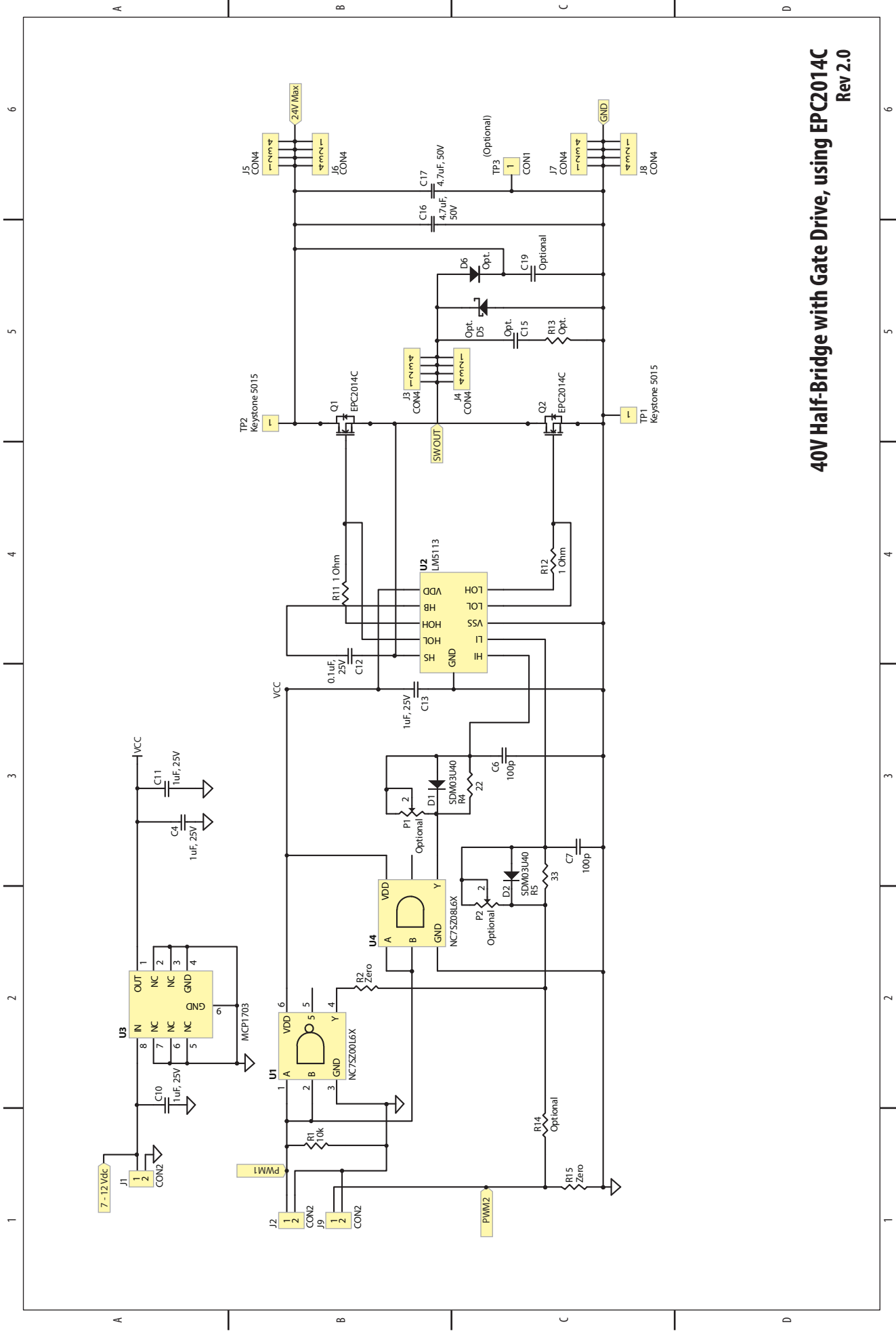


Figure 5: Development Board Schematic